

<b>FORM PTO-1449</b>  <b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>  <b>INFORMATION DISCLOSURE</b> <b>STATEMENT BY APPLICANT</b>  (Use several sheets if necessary)	<b>ATTY. DOCKET NO.</b> NET-P01-2287.01	<b>SERIAL NO.</b> 10/772,643
	<b>APPLICANT</b> Stager et al.	
	<b>FILING DATE</b> February 5, 2004	<b>GROUP</b> 2165

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		2006/0047989	03/2006	Delgado et al.			
		2006/0047998	03/2006	Darcy, Jeff			
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/F.S./		EP 1 671 231	06/2006	Rowan et al.				
		WO2005/031576	04/2005	Rowan et al.				
		WO2006/023990	03/2006	Perry, Robert				
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/F.S./		WO2006/023995	03/2006	Perry, Robert				

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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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